

**Notice of References Cited**

Application/Control No.

10/577,475

Applicant(s)/Patent Under  
Reexamination  
ODAWARA ET AL.

Examiner

TRAN Q. TRAN

Art Unit

2811

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0234400	12-2003	Udagawa, Takashi	257/80
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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